

### **General Description**

The SJD045N10 uses SGT technology to provide excellent R<sub>DS(ON)</sub>, low gate charge and fast switching characteristics. This device is suitable for use as a wide variety of applications.

### Features

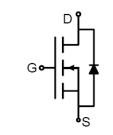
- Low Gate Charge
- 100% UIS Tested, 100% DVDS Tested
- High Power and current handing capability
- Lead free product is acquired

### Application

- DC/DC Converter
- Ideal for high-frequency switching and synchronous rectification

## Key Performance Parametes

Parameter	Value	Unit
V <sub>DS</sub>	100	V
R <sub>DS(ON)_TYP</sub>	5	mΩ
ID	122	А
Q <sub>G</sub>	47	nC







Schematic Diagram

TO-220 top view

### **Package Marking and Ordering Information**

Device/Ordering Code	Marking	Package	Packing	Reel Size	Tape width	Quantity
SJD045N10	SJD045N10	TO-252	Tube	\	١	2500 Pcs

### Table 1. Absolute Maximum Ratings (T<sub>c</sub>=25℃ unless otherwise noted)

Symbol	Parameter	Limit	Unit
V <sub>DS</sub>	Drain-Source Voltage (V <sub>GS</sub> =0V)	100	V
V <sub>GS</sub>	Gate-Source Voltage (V <sub>DS</sub> =0V)	±20	V
1-	Drain Current-Continuous(Tc=25°C)	122	А
ID	Drain Current-Continuous(Tc=100°C)	77	А
IDM (pluse)	Drain Current-Continuous@ Current-Pulsed (Note 1)	488	А
D	Maximum Power Dissipation(Tc=25°C)	171	W
PD	Maximum Power Dissipation(Tc=100°C)	68	W
Eas	Avalanche energy (Note 2)	576	mJ
TJ, TSTG	Operating Junction and Storage Temperature Range	-55 To 150	C

## Table 2. Thermal Characteristic

Symbol	Parameter	Тур	Max	Unit
$R_{ ext{ heta}JC}$	Thermal Resistance, Junction-to-Case		0.73	°C/W



# SJD045N10

## **100V N-Channel SGT Power MOSFET**

## Table 3. Electrical Characteristics (T\_J=25 $^{\circ}$ C unless otherwise noted)

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
On/Off States						
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V I <sub>D</sub> =250µA	100			V
		V <sub>DS</sub> =60V, V <sub>GS</sub> =0V TJ=25℃			1	μA
IDSS	Zero Gate Voltage Drain Current	V <sub>DS</sub> =60V, V <sub>GS</sub> =0V T <sub>J</sub> =125℃			100	μA
lgss	Gate-Body Leakage Current	$V_{GS}=\pm 20V, V_{DS}=0V$			±100	nA
$V_{GS(th)}$	Gate Threshold Voltage	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250µA	2		4	V
<b>g</b> fs	Forward Transconductance	V <sub>DS</sub> =5V, I <sub>D</sub> =20A		28		S
RDS(ON)	Drain-Source On-State Resistance	V <sub>GS</sub> =10V, I <sub>D</sub> =20A T <sub>J</sub> =25℃		5	6.2	mΩ
Dynamic Chara	acteristics					
Ciss	Input Capacitance			2944		pF
Coss	Output Capacitance	V <sub>DS</sub> =25V,V <sub>GS</sub> =0V, f=1.0MHz		1551		pF
Crss	Reverse Transfer Capacitance		-	71.9		pF
Rg	Gate resistance	V <sub>GS</sub> =0V, V <sub>DS</sub> =0V, f=1.0MHz		1.7		Ω
Switching Para	meters		L		L	
t <sub>d(on)</sub>	Turn-on Delay Time			22.4		nS
tr	Turn-on Rise Time	V <sub>GS</sub> =10V, V <sub>DS</sub> =50V, R <sub>L</sub> =2.5Ω, R <sub>GEN</sub> =6Ω	-	6.6		nS
$t_{d(off)}$	Turn-Off Delay Time			33.2		nS
t <sub>f</sub>	Turn-Off Fall Time			7.6		nS
Qg	Total Gate Charge			47		nC
Q <sub>gs</sub>	Gate-Source Charge	V <sub>GS</sub> =10V, V <sub>DS</sub> =50V, I <sub>D</sub> =20A	-	14.2		nC
$Q_{gd}$	Gate-Drain Charge		-	9.8		nC
Source-Drain D	Diode Characteristics					
I <sub>SD</sub>	Source-Drain Current (Body Diode)				122	Α
V <sub>SD</sub>	Forward on Voltage (Note 3)	V <sub>GS</sub> =0V, I <sub>S</sub> =20A			1.2	V
t <sub>rr</sub>	Reverse Recovery Time	l⊧=20A, dl/dt=100A/μs		49.2		ns
Qrr	Reverse Recovery Charge	I⊧=20A, dI/dt=100A/μs		54.1		nC

Notes 1.Repetitive Rating: Pulse width limited by maximum junction temperature.

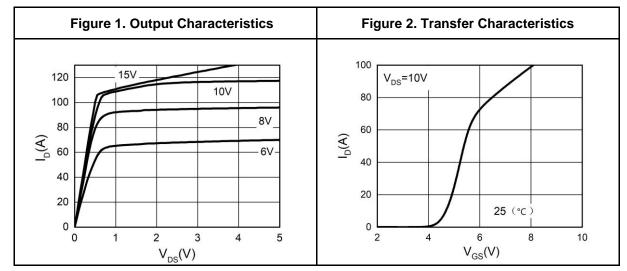
Notes 2.EAS condition: TJ=25  $^\circ C$  ,VDD=50V,VG=10V, Rg=25\Omega, L=0.5mH.

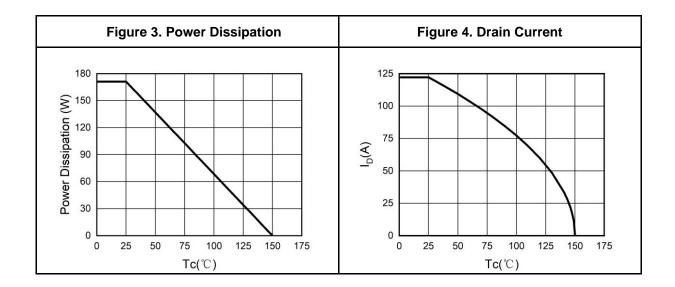
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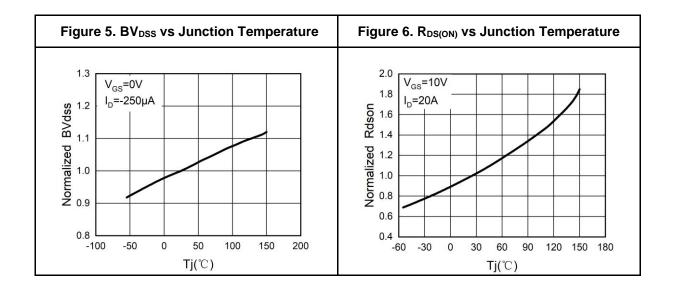




## **Typical Electrical And Thermal Characteristics (Curves)**





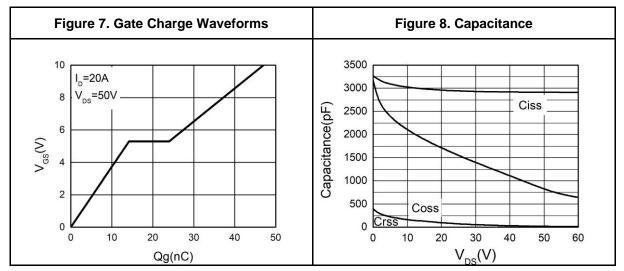


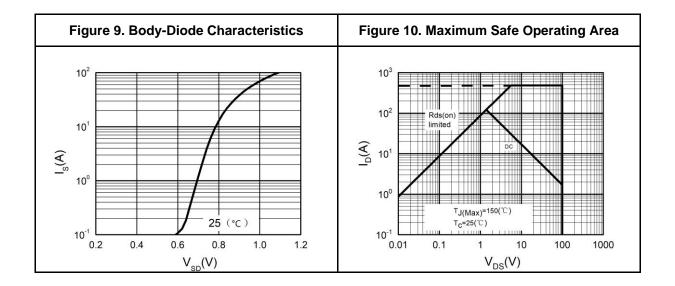


# SJD045N10

# **100V N-Channel SGT Power MOSFET**

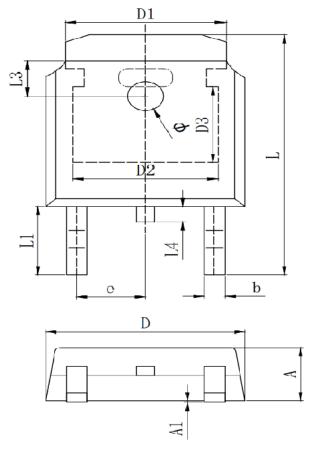
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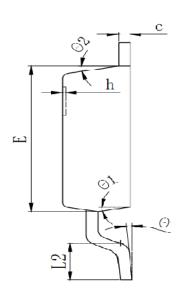






# **TO-252 Package Information**





Symbol	Dimensions In Millimeters			
Symbol	Min.	Тур.	Max.	
А	2.200	2.300	2.400	
A1	0.000		0.127	
b	0.640	0.690	0.740	
<b>c(</b> 电镀后)	0.460	0.520	0.580	
D	6.500	6.600	6.700	
D1		5.334 REF		
D2		4.826 REF		
D3		3.166 REF		
E	6.000	6.100	6.200	
е		2.286 TYP		
h	0.000	0.100	0.200	
L	9.900	10.100	10.300	
L1		2.888 REF		
L2	1.400	1.550	1.700	
L3		1.600 REF		
L4	0.600	0.800	1.000	
Φ	1.100	1.200	1.300	
θ	0°		8°	
θ1	9° TYP			
θ2		9° TYP		



## Attention

This product described in this document can not be used in life support devices or systems, aircraft's control systems, and other applications whose failure can be reasonably expected to result in serious physical and/or material damage, apart from that when an application agreement is signed between customer and Wuxi Shangjia Semiconductor

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